

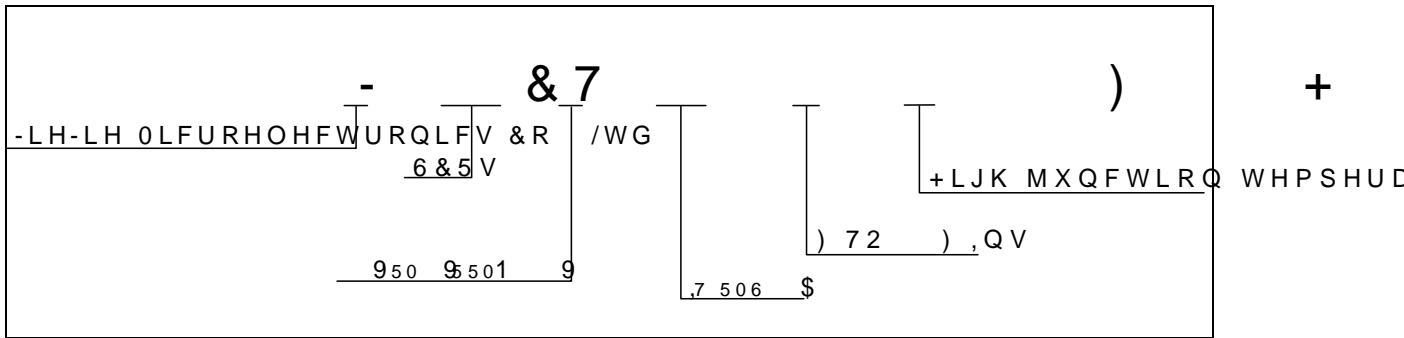


\$YHUDJH JDWH SRZHU GLVVLS\$D\$WLRQ 7		
3HDN JDWH SRZHU	3*0	:
3HDN SXOVH YROWDJH 7M QRQ UHSHWLWLYH RII VWDWH),*	9SS	

E> ECd Z / CA> C, AZ ACd EZX/Q^OdH/C^RWKHUZLVH VSHFLILHG

Symbol	Test Condition	Value			Unit
		MIN.	TYP.	MAX.	
,*7	9' 9 5				P\$
9*7					9
9*'	9' 9'50 7M				

K Z E Z / E ' / E & K Z D Ad / K E



D AZ < / E '

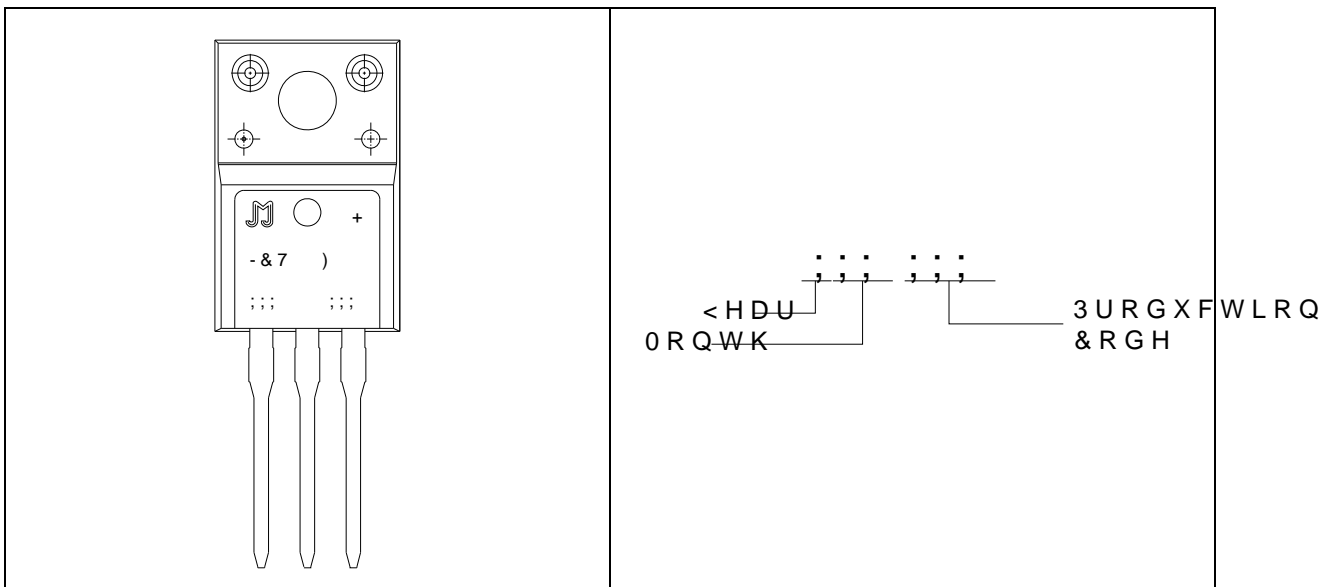




FIG.1: 0D[LPXP SRZHU GLVVLSDW 506 RQ VWDWH FXUUHQ WHPHUDWXUH

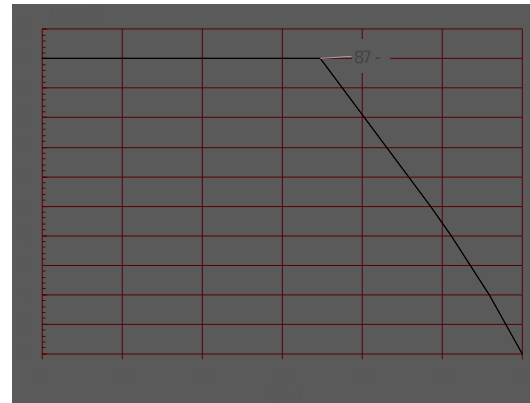
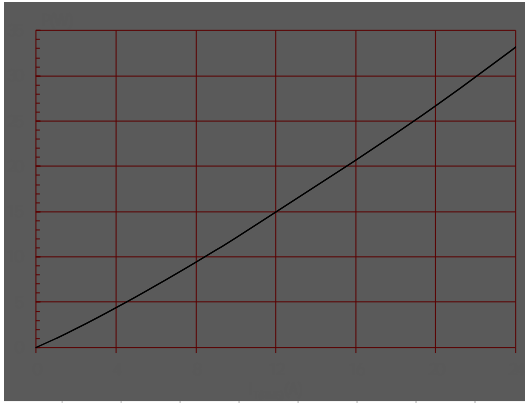
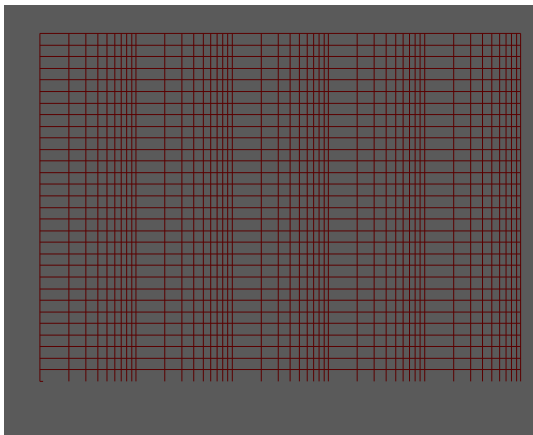


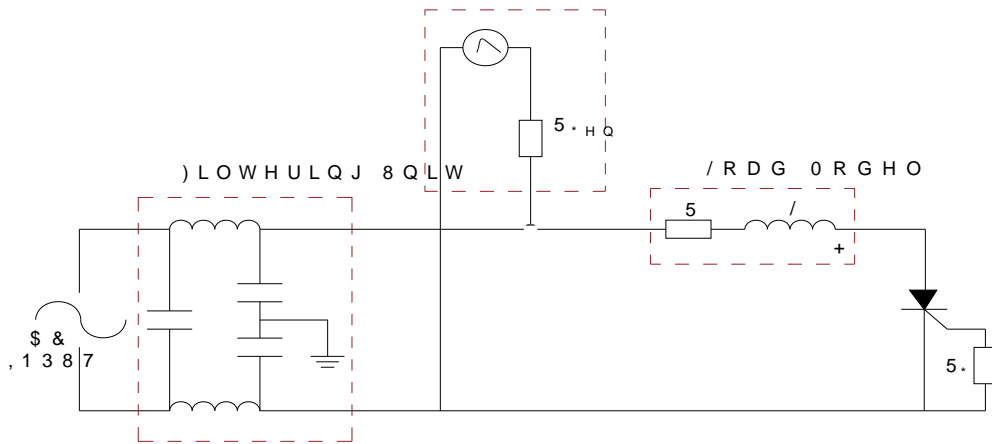
FIG.3: 6XUJH SHDN RQ VWDWH FKHDFWHULVWLFV QXPEHU RI F\FOHV





), * Ö7HVW FLUFXLW IRUHVQGW EWHYOR DQG WR , (&

, (&
6 X U J H * H Q H U D W R U
6 Y R O W D J H V X U J H
6 F X U U H Q W V X U J H





K Z E Z / E ' / E & K Z D Ad / K E

Order code	Voltage V _{DRM} /V _{RRM} (V)	IGT(mA)	Package	Base qty. (pcs)	Delivery mode
JCT820FH	800	15	TO-220F(Ins)	50	Tube

Document Revision History

'DWH	5HYLVLRQ	&KDQJHV
-XQ	\$	/DVW XSGDWH
2FW	\$	5HYLVLRQ. \$*(0(&+\$1, &\$/'\$7\$

JCT820FH



JieJie Microelectronics Co., Ltd.

W AC< A' E D EC, AE / CA> Ad A

